Docket No.

249083US2S

# IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF:

Daisaburo TAKASHIMA

SERIAL NO: NEW APPLICATION

GAU:

FILED:

**HEREWITH** 

**EXAMINER:** 

FOR:

SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE

## INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

#### REFERENCES

	The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
	A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).
REL	ATED CASES
	Attached is a list of applicant's pending application(s) or issued patent(s) which may be related to the present application. A copy of the patent(s), together with a copy of the claims and drawings of the pending application(s) is attached along with PTO 1449.
	A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).
CER	TIFICATION
	Each item of information contained in this information disclosure statement was first cited in any communication

#### C

Each item of information contained in this information disclosure statement was first cited in any communication
from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of
this statement.

□ No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

### **DEPOSIT ACCOUNT**

Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.

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C. Irvin McClelland Registration Number 21,124

Form PTO 1449		U.S. DEPARTMENT O	F COMMERCE	ATTY DOCKET NO.			SERIAL NO.			
(Modified) PATENT AND TI			MARK OFFICE	249083US2S		NEW APPLICATION				
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LIST OF	REFER	RENCES CITED BY APP	LICANT	Daisaburo TAKASHIMA						
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		OTHER RE	FERENCES	Including Author, Title, Date, Pertiner	nt Pages, e	tc.)		someth		
	AW	Daisaburo TAKASHIMA, et al., "High-Density Chain Ferroelectric Random Access Memory (Chain FRAM)", IEEE JOURNAL OF SOLID-STATE CIRCUITS, Vol. 33, No. 5, May 1998, pgs. 787-792.								
	AX	Daisaburo TAKASHIMA, "Overview and Trend of Chain FeRAM Architecture", IEICE TRANS. ELECTRON, Vol. E84-C, No. 6, June 2001, pgs. 747-756.								
	AY	Shigeo ONISHI, et al., "A Half-Micron Ferroelectric Memory Cell Technology with Stacked Capacitor Structure", IEDM, Dec. 1994, pgs. 843-846.								
	AZ	Additional References sheet(s) attached								
Examiner		L		<u> </u>	Date Co	ate Considered				
*Examiner: Ir conformance	nitial if r	eference is considered, of considered. Include co	whether or no py of this for	at citation is in conformance with MPEP $\epsilon$ n with next communication to applicant.	609; Draw li	ine through	citation	if not in		